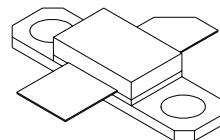


## **30W, 1GHz, 26V Broadband RF Power N-Channel Enhancement-Mode Lateral DMOS**

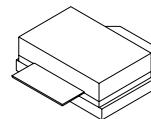
This device is designed for base station applications up to frequencies of 1GHz. Rated with a minimum output power of 30W, it is ideal for CDMA, TDMA, GSM, FM, Single or Multi-Carrier Power Amplifiers in Class A or AB operation.

- Industry standard package.
- Low intermodulation distortion of -30dBc at 30W (PEP).
- Gold Metalization, Gold Bond Wires, Gold-Plated Packages.



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Package Type 440095  
UPF1030F



Package Type 440134  
UPF1030P

# UPF1030

## Maximum Ratings

Rating	Symbol	Value	Unit
Drain to Source Voltage, gate connected to source	$V_{DSS}$	65	Volts
Gate to Source Voltage	$V_{GS}$	+/- 20	Volts
Total Device Dissipation @ Tcase = 70°C Derate above 70°C	$P_D$	65 0.5	Watts W/°C
Storage Temperature Range	$T_{STG}$	-65 to +150	°C
Operating Junction Temperature	$T_J$	200	°C

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## Thermal Characteristics

Characteristics	Symbol	Typical	Maximum	Unit
Thermal Resistance, Junction to Case	$\Theta_{JC}$	1.6	1.75	°C/W

## Electrical DC Characteristics ( $T_C=25^\circ\text{C}$ unless otherwise specified)

Rating	Symbol	Min	Typ	Max	Unit
Drain to Source Voltage, gate connected to source ( $V_{GS}=0$ , $I_{DS}=1\text{mA}$ )	$BV_{DSS}$	65	-	-	Volts
Drain to Source Leakage current ( $V_{DS}=28\text{V}$ , $V_{GS}=0$ )	$I_{DSS}$	-	-	1.0	mA
Gate to Source Leakage current ( $V_{GS}=20\text{V}$ , $V_{DS}=0$ )	$I_{GSS}$	-	-	1.0	$\mu\text{A}$
Threshold Voltage ( $V_{DS}=10\text{V}$ , $I_{DS}=1\text{mA}$ )	$V_{TH}$	2.0	3.5	5.0	Volts
Gate Quiescent Voltage ( $V_{DS}=26\text{ V}$ , $I_{DS}=200\text{mA}$ )	$V_{GS}(\text{on})$	3.0	4.0	6.0	Volts
Drain to Source On Voltage ( $V_{GS}=10\text{V}$ , $I_{DS}=1\text{A}$ )	$V_{DS}(\text{on})$	-	0.28	-	Volts
Forward Transconductance ( $V_{DS}=10\text{V}$ , $I_D=5\text{A}$ )	$G_M$	1.4	1.8	-	S

**UPF1030****AC Characteristics** ( $T_C=25^\circ\text{C}$  unless otherwise specified)

Rating	Symbol	Min	Typ	Max	Unit
Input Capacitance ( $V_{DS}=26\text{V}$ , $V_{GS}=0$ , freq= 1MHz)	$C_{ISS}$	-	44	-	pF
Output capacitance ( $V_{DS}=26\text{V}$ , $V_{GS}=0\text{V}$ , freq= 1MHz)	$C_{OSS}$	-	26	-	pF
Feedback capacitance ( $V_{DS}=26\text{V}$ , $V_{GS}=0\text{V}$ , freq= 1MHz)	$C_{RSS}$	-	1.2	-	pF

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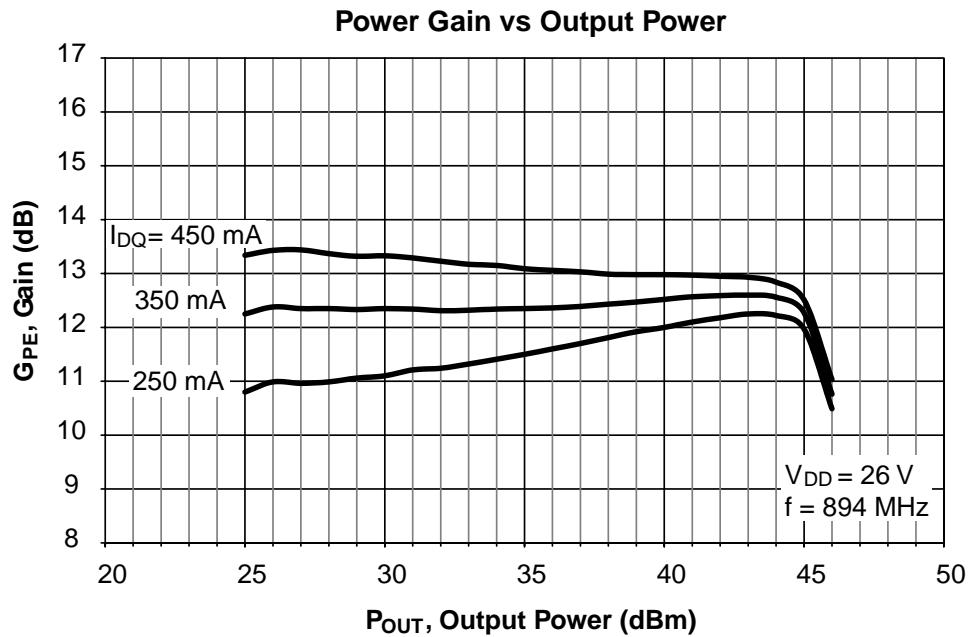
**RF and Functional Tests** ( $T_C=25^\circ\text{C}$  unless otherwise specified, UltraRF Broadband Fixture)

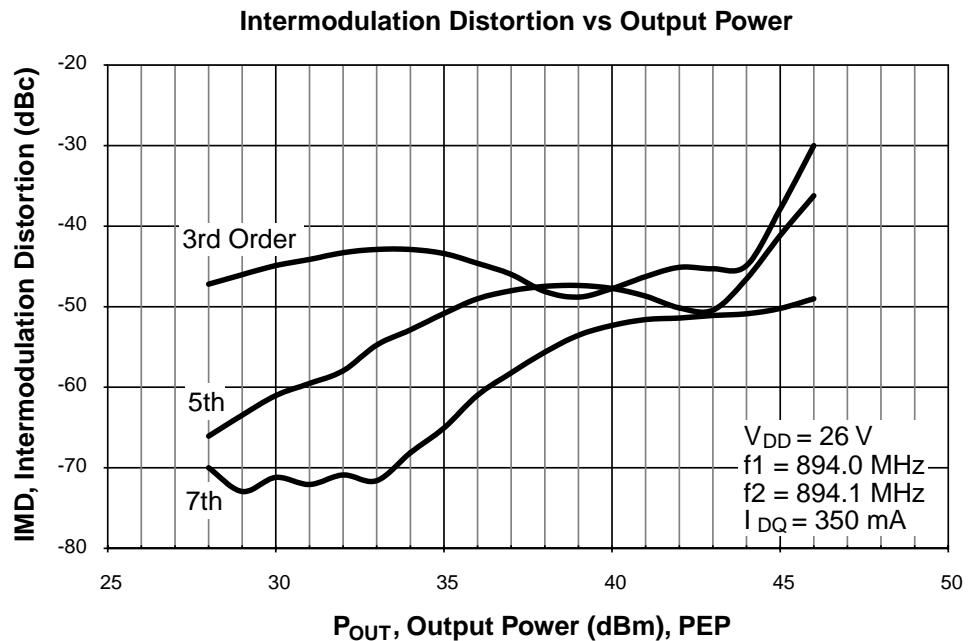
Rating	Symbol	Min	Typ	Max	Unit
Linear Power Gain, Single Tone ( $V_{DS}=26\text{V}$ , $I_{DQ}=350\text{mA}$ , $P_{OUT}=5\text{W}$ , $f=894\text{ MHz}$ )	$G_{plin}$	13	14.5	-	dB
Compressed Power Gain, Single tone ( $V_{DS}=26\text{V}$ , $I_{DQ}=350\text{mA}$ , $P_{OUT}=30\text{W}$ , $f=894\text{ MHz}$ )	$G_{ps}$	12	14	-	dB
Drain Efficiency, Single Tone ( $V_{DS}=26\text{V}$ , $I_{DQ}=350\text{mA}$ , $P_{OUT}=30\text{W}$ , $f=894\text{ MHz}$ )	$\eta$	45	52	-	%
Intermodulation Distortion, Two Tone ( $V_{DS}=26\text{V}$ , $I_{DQ}=350\text{mA}$ , $P_{OUT}=30\text{W PEP}$ $f_1=894\text{ MHz}$ , $f_2=894.1\text{MHz}$ )	IMD	-	-35	-30	dBc
Load Mismatch Tolerance ( $V_{DS}=26\text{V}$ , $I_{DQ}=350\text{mA}$ , $P_{OUT}=30\text{W}$ , $f=894\text{ MHz}$ )	VSWR	10:1	-	-	

**CAUTION -** MOS Devices are susceptible to damage from ElectroStatic Discharge (ESD). Appropriate precautions in handling, packaging and testing MOS devices must be observed.

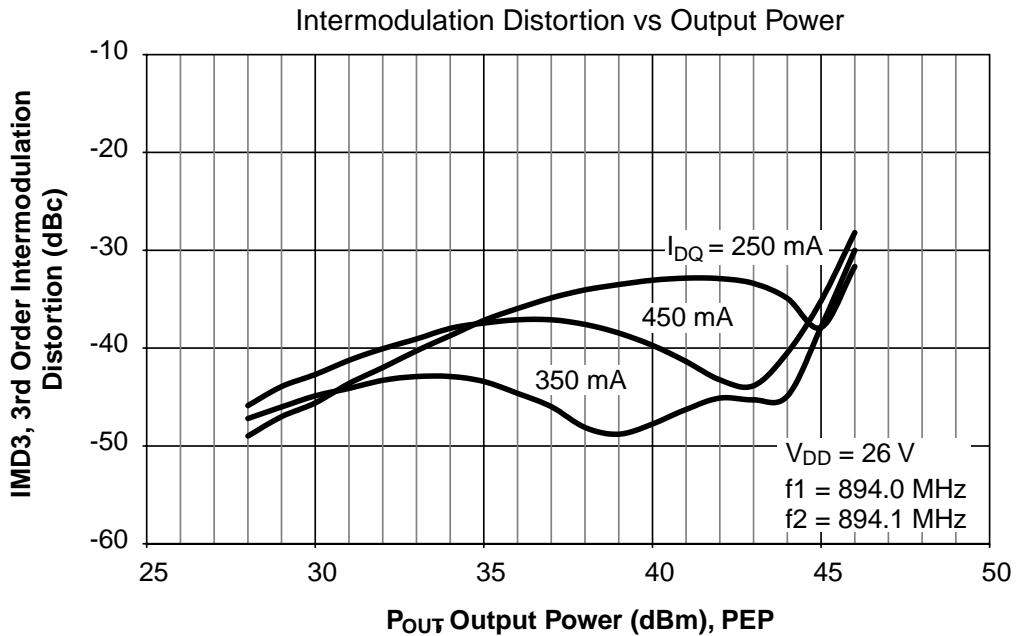
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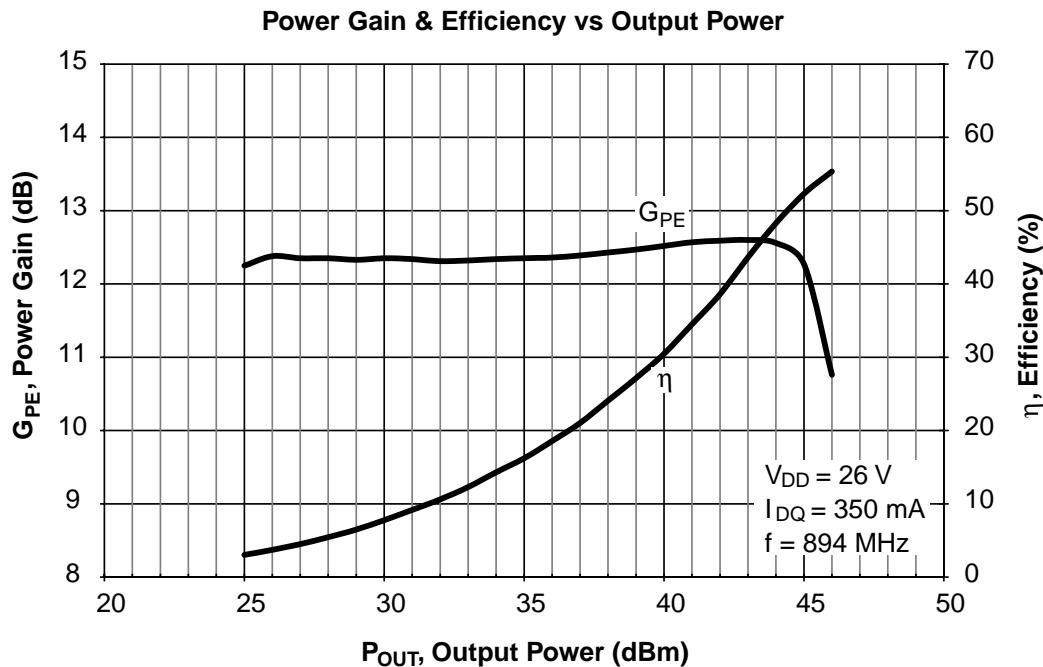
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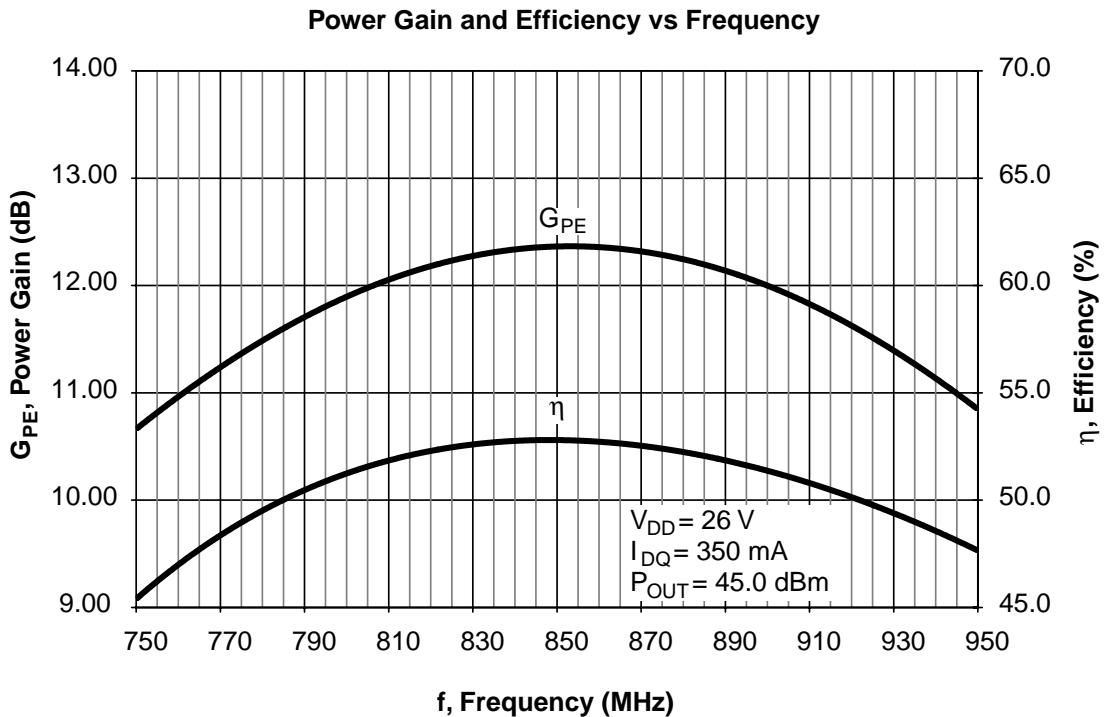
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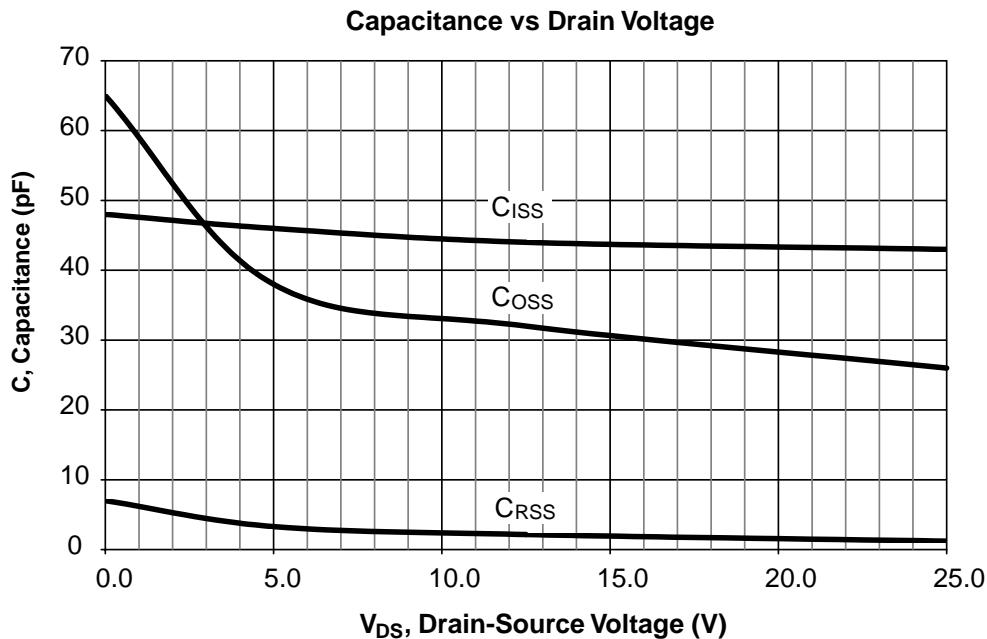




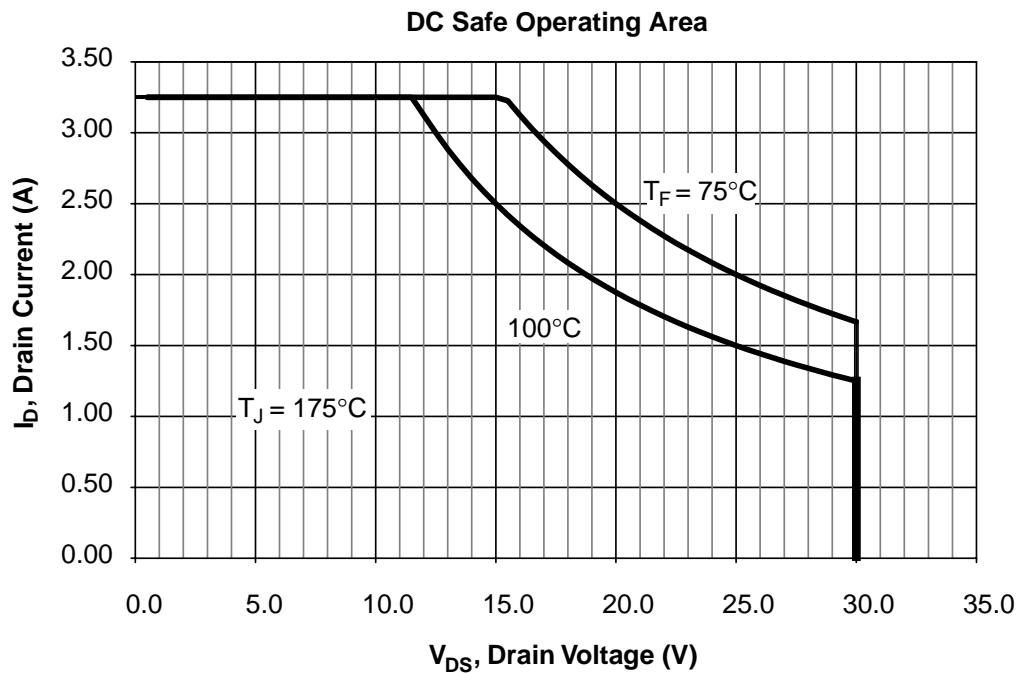
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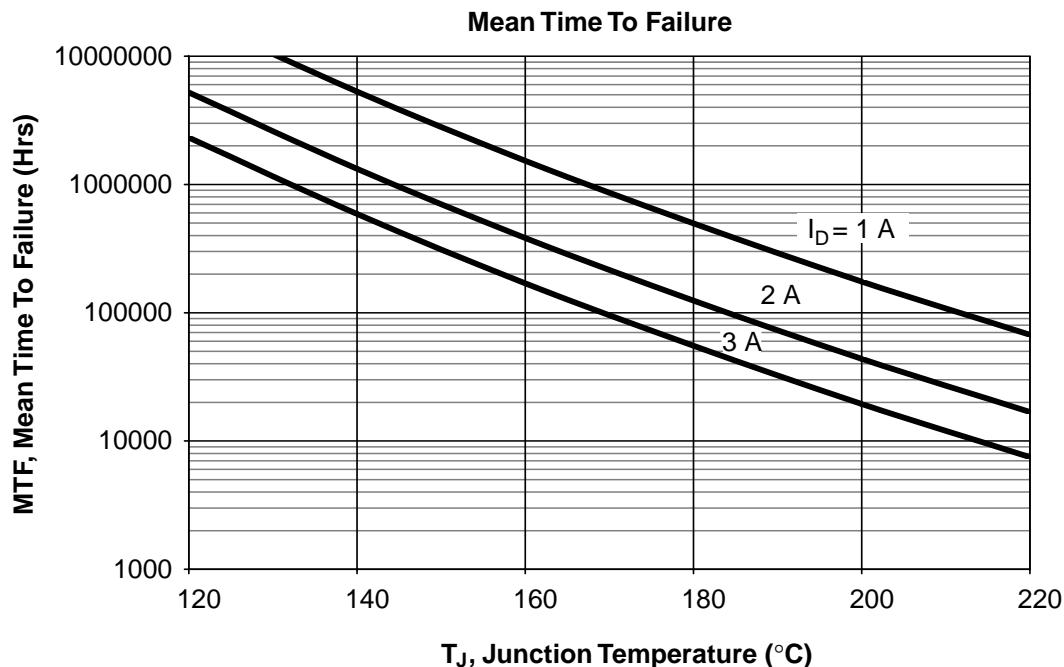
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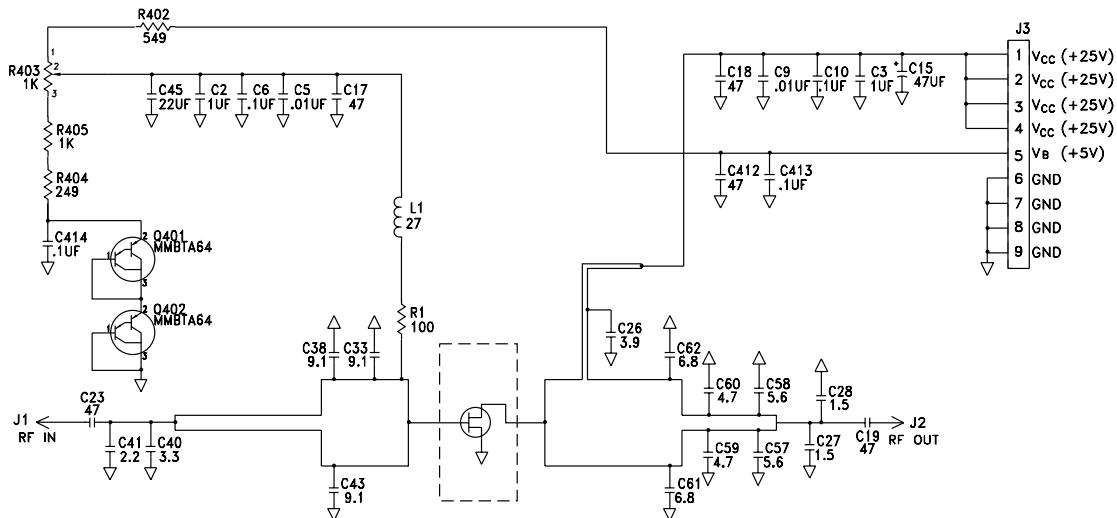
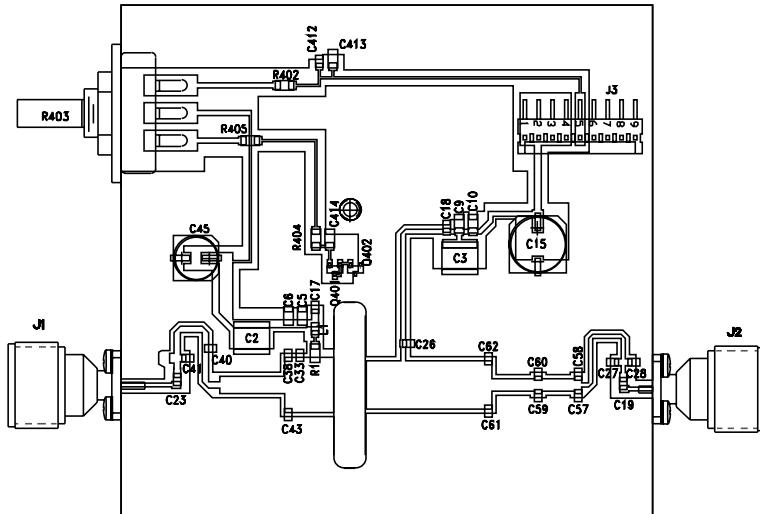


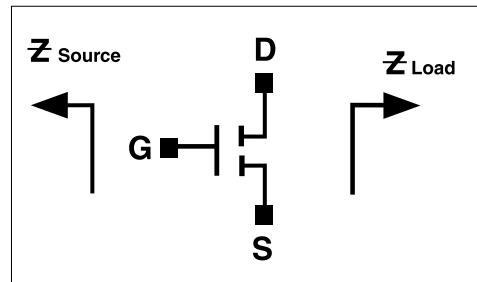
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UPF1030





Frequency (MHz)	Z Source	Z Load
800	1.58- j1.84	3.36 + j2.03
810	1.57- j1.83	3.44 + j2.03
820	1.56- j1.77	3.50 + j2.09
830	1.56- j1.70	3.60 + j2.11
840	1.56- j1.63	3.67 + j2.12
850	1.54- j1.58	3.73 + j2.13
860	1.53- j1.56	3.80 + j2.15
870	1.50- j1.52	3.85 + j2.16
880	1.50- j1.51	3.92 + j2.16
890	1.49- j1.48	3.99 + j2.18
900	1.49- j1.46	4.06 + j2.16

# UPF1030

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